Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/939,134	SESTOK ET AL.
Examiner	Art Unit
Erin M Eilo	2634

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	219	10/20/2004	EMF
	<u></u>		<u></u>

ERFERENC	ERFERENCE SEARCHED		
Subclass	Date	Examiner	
	1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only— see search history printout)	10/20/2004	EMF		
PALM INVENTORSHIP	10/20/2004	EMF		